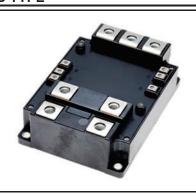


<IGBT Modules>

# CM1200DW-34T

HIGH POWER SWITCHING USE **INSULATED TYPE** 



Collector current Ic ...... 1 2 0 0 A Collector-emitter voltage V<sub>CES</sub> ...... 1 7 0 0 V Maximum junction temperature T<sub>vjmax</sub> ....... 1 7 5 °C

- Dual switch (Half-bridge)
- Copper base plate (Nickel-plating)
- Ni-plating signal terminals
- •RoHS Directive compliant
- •UL Recognized under UL1557, File No. E323585

#### **APPLICATION**

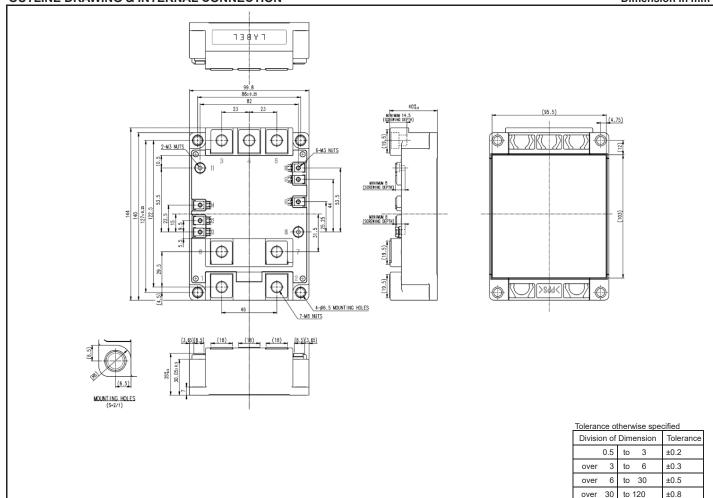
AC motor control, Wind power, etc.

**OPTION** (Below options are available.)

- $\bullet \mathsf{PC}\text{-}\mathsf{TIM} \ (\underline{P}\mathsf{hase} \ \underline{C}\mathsf{hange} \ \underline{T}\mathsf{hermal} \ \underline{I}\mathsf{nterface} \ \underline{M}\mathsf{aterial}) \ \mathsf{pre}\text{-}\mathsf{apply}$
- •VcEsat selection for parallel connection



Dimension in mm

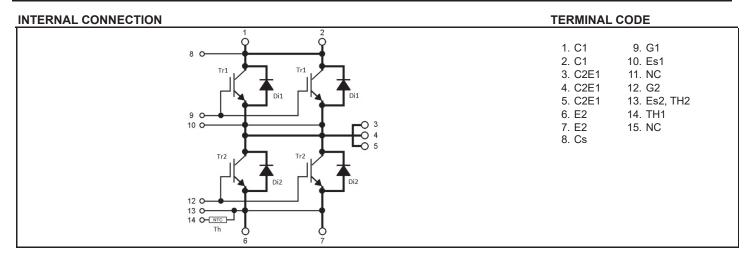


over 120

±1.2

HIGH POWER SWITCHING USE

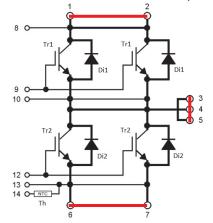
INSULATED TYPE



### **NOTE**

Terminal 1 and 2, Terminal 3,4 and 5, Terminal 6 and 7,

These terminals should be connected respectively when it is used.



HIGH POWER SWITCHING USE

INSULATED TYPE

MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

| Symbol                   | Item                           | Conditions                                   | Rating     | Unit |
|--------------------------|--------------------------------|----------------------------------------------|------------|------|
| V <sub>CES</sub>         | Collector-emitter voltage      | G-E short-circuited                          | 1700       | V    |
| V <sub>GES</sub>         | Gate-emitter voltage           | C-E short-circuited                          | ± 20       | V    |
| Ic                       | Callantan aumant               | DC, T <sub>C</sub> =69 °C (Note2, 4)         | 1200       | ^    |
| I <sub>CRM</sub>         | Collector current              | Pulse, Repetitive (Note3)                    | 2400       | A    |
| P <sub>tot</sub>         | Total power dissipation        | T <sub>C</sub> =25 °C (Note2, 4)             | 5355       | W    |
| I <sub>E</sub> (Note1)   | F                              | DC (Note2)                                   | 1200       |      |
| I <sub>ERM</sub> (Note1) | Emitter current                | Pulse, Repetitive (Note3)                    | 2400       | A    |
| Visol                    | Isolation voltage              | Teminals to base plate, RMS, f=60Hz, AC 1min | 4000       | V    |
| T <sub>vj max</sub>      | Maximum junction temperature   | Instaneous event (overload) (Note9)          | 175        | °C   |
| T <sub>c max</sub>       | Maximum case temperature       | (Note4, 9)                                   | 125        | °C   |
| T <sub>vj op</sub>       | Operating junction temperature | Continuous operation (Note9)                 | -40 ~ +150 | 00   |
| T <sub>stg</sub>         | Storage temperature            | -                                            | -40 ~ +125 | °C   |

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

| Cumbal                  | Item Condition                       |                                                                                                                |                                                         | Limits |      |      | Unit |
|-------------------------|--------------------------------------|----------------------------------------------------------------------------------------------------------------|---------------------------------------------------------|--------|------|------|------|
| Symbol                  | item                                 | Conditions                                                                                                     |                                                         | Min.   | Тур. | Max. | 7 Un |
| CES                     | Collector-emitter cut-off current    | V <sub>CE</sub> =V <sub>CES</sub> , G-E short-circuited                                                        |                                                         | -      | -    | 1.0  | mA   |
| GES                     | Gate-emitter leakage current         | V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited                                                        | V <sub>GE</sub> =V <sub>GES</sub> , C-E short-circuited |        | -    | 0.5  | μΑ   |
| $V_{\rm GE(th)}$        | Gate-emitter threshold voltage       | I <sub>C</sub> =120 mA, V <sub>CE</sub> =10 V                                                                  |                                                         | 5.4    | 6    | 6.6  | V    |
|                         |                                      | I <sub>C</sub> =1200 A (Note5)                                                                                 | T <sub>vj</sub> =25 °C                                  | -      | 2.00 | 2.40 | V    |
|                         |                                      | V <sub>GE</sub> =15 V,                                                                                         | T <sub>vj</sub> =125 °C                                 | -      | 2.40 | -    |      |
| ,                       |                                      | (Terminal)                                                                                                     | T <sub>vj</sub> =150 °C                                 | -      | 2.50 | -    |      |
| CEsat                   | Collector-emitter saturation voltage | I <sub>C</sub> =1200 A (Note5)                                                                                 | T <sub>vj</sub> =25 °C                                  | -      | 1.95 | 2.35 |      |
|                         |                                      | V <sub>GE</sub> =15 V,                                                                                         | T <sub>vj</sub> =125 °C                                 | -      | 2.35 | -    | V    |
|                         |                                      | (Chip)                                                                                                         | T <sub>vj</sub> =150 °C                                 | -      | 2.45 | -    |      |
| ies                     | Input capacitance                    |                                                                                                                |                                                         |        |      | 330  |      |
| `<br>'oes               | Output capacitance                   | V <sub>CE</sub> =10 V, V <sub>GE</sub> =0V                                                                     |                                                         | -      | -    | 8.7  | nF   |
| res                     | Reverse transfer capacitance         |                                                                                                                | -                                                       | -      | 2.8  |      |      |
| Q <sub>G</sub>          | Gate charge                          | V <sub>CC</sub> =1000 V, I <sub>C</sub> =1200 A, V <sub>GE</sub> =15 V                                         |                                                         | -      | 9.4  | -    | μ    |
| d(on)                   | Turn-on delay time                   | V 4000 V L 4000 A V 45 V                                                                                       | -                                                       | -      | 800  | ns   |      |
| r                       | Rise time                            | V <sub>CC</sub> =1000 V, I <sub>E</sub> =1200 A, V <sub>GE</sub> =±15 V,                                       | -                                                       | -      | 200  |      |      |
| d(off)                  | Turn-off delay time                  |                                                                                                                |                                                         | -      | -    |      | 800  |
| f                       | Fall time                            | $R_G$ =0 Ω, Inductive load                                                                                     | Ī                                                       | -      | -    | 600  |      |
|                         |                                      | I <sub>E</sub> =1200 A <sup>(Note5)</sup>                                                                      | T <sub>vj</sub> =25 °C                                  | -      | 2.70 | 3.30 | V    |
|                         | Emitter-collector voltage            | G-E short-circuited                                                                                            | T <sub>vj</sub> =125 °C                                 | -      | 2.80 | -    |      |
| (Note1)                 |                                      | (Terminal)                                                                                                     | T <sub>vj</sub> =150 °C                                 | -      | 2.80 | -    |      |
| EC (Note1)              |                                      | I <sub>E</sub> =1200 A <sup>(Note5)</sup> ,                                                                    | T <sub>vj</sub> =25 °C                                  | -      | 2.65 | 3.25 |      |
|                         |                                      | G-E short-circuited,                                                                                           | T <sub>vj</sub> =125 °C                                 | -      | 2.75 | -    | V    |
|                         |                                      | (Chip)                                                                                                         | T <sub>vj</sub> =150 °C                                 | -      | 2.75 | -    |      |
| (Note1)                 | Reverse recovery time                | V <sub>CC</sub> =1000 V, I <sub>E</sub> =1200 A, V <sub>GE</sub> =±15 V,                                       |                                                         | -      | -    | 300  | n    |
| Q <sub>rr</sub> (Note1) | Reverse recovery charge              | R <sub>G</sub> =0 Ω, Inductive load                                                                            |                                                         | -      | 72   | -    | μ(   |
| on                      | Turn-on switching energy per pulse   | $V_{CC}$ =1000V, $I_C$ = $I_E$ =1200A, $V_{GE}$ =±15V, $R_G$ =0 $\Omega$ , $T_{\nu j}$ =150°C, Inductive loard |                                                         | -      | 138  | -    |      |
| off                     | Turn-off switching energy per pulse  |                                                                                                                |                                                         | -      | 309  | -    | m    |
| (Note1)                 | Reverse recovery energy per pulse    |                                                                                                                |                                                         | -      | 220  | -    | 1    |
| CC'+EE'                 | Internal lead resistance             | Main terminals-chip Tc=25°C (Note4)                                                                            |                                                         | -      | 0.25 | -    | m    |
| g                       | Internal gate resistance             | Per switch                                                                                                     |                                                         | _      | 0.67 |      | Ω    |

### HIGH POWER SWITCHING USE

#### **INSULATED TYPE**

#### NTC THERMISTOR PART

| Symbol               | Item                    | Conditions                                              |      | Unit |      |       |
|----------------------|-------------------------|---------------------------------------------------------|------|------|------|-------|
|                      |                         | Conditions                                              | Min. | Тур. | Max. | Offic |
| R <sub>25</sub>      | Zero-power resistance   | T <sub>C</sub> =25 °C (Note4)                           | 4.85 | 5.00 | 5.15 | kΩ    |
| ΔR/R                 | Deviation of resistance | R <sub>100</sub> =493 Ω, T <sub>C</sub> =100 °C (Note4) | -7.3 | -    | +7.8 | %     |
| B <sub>(25/50)</sub> | B-constant              | Approximate by equation (Note6)                         | -    | 3375 | -    | K     |
| P <sub>25</sub>      | Power dissipation       | T <sub>C</sub> =25 °C (Note4)                           | -    | -    | 10   | mW    |

#### THERMAL RESISTANCE CHARACTERISTICS

| Symbol                | Item                       | Conditions                                                             | Limits                              |      |      | Unit  |  |
|-----------------------|----------------------------|------------------------------------------------------------------------|-------------------------------------|------|------|-------|--|
| Syllibol              |                            | Conditions                                                             | Min.                                | Тур. | Max. | UIIIL |  |
| R <sub>th(j-c)Q</sub> | Thermal resistance         | Junction to case, per IGBT switch <sup>(Note4)</sup>                   | er IGBT switch <sup>(Note4)</sup> - |      | 28   | K/kW  |  |
| R <sub>th(j-c)D</sub> | Thermal resistance         | Junction to case, per FWD seitch <sup>(Note4)</sup>                    | -                                   | -    | 43   | r/KVV |  |
| R <sub>th(c-s)</sub>  | Contact thermal resistance | Case to heat sink, per 1 module,<br>Thermal grease applied (Note4,7,9) | -                                   | 10   | -    | K/kW  |  |

#### MECHANICAL CHARACTERISTICS

| Symbol         | Item                   | Conditions                     |           |      | Unit |      |       |  |
|----------------|------------------------|--------------------------------|-----------|------|------|------|-------|--|
| Symbol         |                        |                                |           | Min. | Тур. | Max. | Offic |  |
| M <sub>t</sub> |                        | Main terminals                 | M 8 screw | 7.0  | 10.5 | 14.0 |       |  |
| Ms             | Mounting torque        | Mounting to heat sink          | M 6 screw | 3.5  | 4.0  | 4.5  | N·m   |  |
| M <sub>t</sub> |                        | Auxiliary terminals            | M 3 screw | 0.4  | 0.5  | 0.6  |       |  |
| d              | Q.,                    | Terminal to terminal           |           | 17   | -    | -    |       |  |
| d <sub>s</sub> | Creepage distance      | Terminal to base plate         |           | 30   | -    | -    | mm    |  |
|                | Classana               | Terminal to terminal           |           | 8.5  | -    | -    |       |  |
| d <sub>a</sub> | Clearance              | Terminal to vase plate         |           | 28   | -    | -    | mm    |  |
| ec             | Flatness of base plate | On the centerline X, Y (Note8) |           | 0    | -    | +200 | μm    |  |
| m              | mass                   | -                              |           | -    | 860  | -    | g     |  |

<sup>\*:</sup> This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

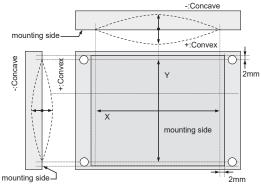
Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

- 2. Junction temperature  $(T_{\nu j})$  should not increase beyond  $T_{\nu j \, m \, a \, x}$  rating.
- 3. Pulse width and repetition rate should be such that the device junction temperature  $(T_{vj})$  dose not exceed  $T_{vjmax}$  rating.
- 4. Case temperature (T<sub>C</sub>) and heat sink temperature (T<sub>S</sub>) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
- 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
- 6.  $B(25/50) \ln \left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} \frac{1}{T_{50}}\right)$

R<sub>25</sub>: resistance at absolute temperature T<sub>25</sub> [K]; T<sub>25</sub>=25 [°C]+273.15=298.15 [K]

 $R_{50}$ : resistance at absolute temperature  $T_{50}$  [K];  $T_{50}$ =50 [°C]+273.15=323.15 [K]

- 7. Reference value. Thermally conductive grease of thermal conductivity  $\lambda$ =0.9 W/(m·K) and thickness D(C-S)=50  $\mu$ m.
- 8. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



9. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under user's specific application conditions. Each temperature condition (T<sub>vj max</sub>, T<sub>vj op</sub>, T<sub>C max</sub>) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

### HIGH POWER SWITCHING USE

INSULATED TYPE

#### RECOMMENDED OPERATING CONDITIONS

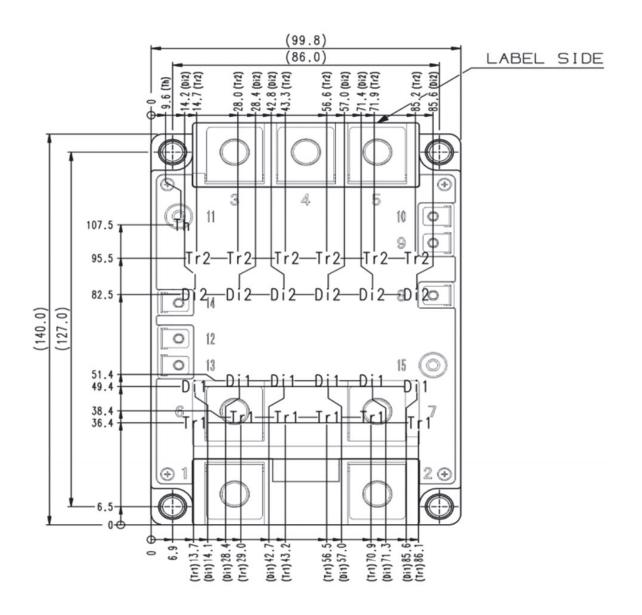
| Symbol          | Item                       | Conditions                             |      | Limits |      |       | Unit |
|-----------------|----------------------------|----------------------------------------|------|--------|------|-------|------|
| Symbol          |                            | Conc                                   | Min. | Тур.   | Max. | Offic |      |
| V <sub>CC</sub> | (DC) Supply voltage        | Applied across C1-E2 terminals         |      | -      | 1000 | 1200  | V    |
| $V_{GEon}$      | Gate-emitter drive voltage | Applied across G1-Es1/G2-Es2 terminals |      | 13.5   | 15.0 | 16.5  | V    |
| Rg              | External gate resistance   | Per switch                             | on   | 0      | 1    | 6.8   | Ω    |
| ING             |                            | off                                    |      | 0      | -    | 15    | Ω    |

Optimum operating conditions should be selected with careful confirmation for no occurrence of any maximum rating violation

(T<sub>VI</sub>, V<sub>CES</sub>, etc.) or any unexpected malfunction (arm-short-through, oscillation, etc.) at the actual application conditions.

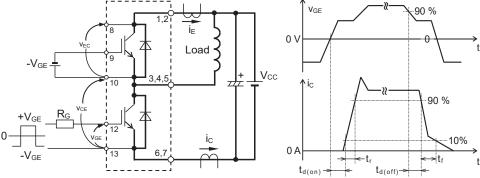
#### CHIP LOCATION (Top view)

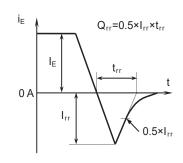
Dimension in mm, tolerance: ±1 mm



Tr1/Tr2: IGBT, Di1/Di2: FWD, Th: NTC thermistor

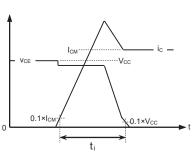
#### **TEST CIRCUIT AND WAVEFORMS**

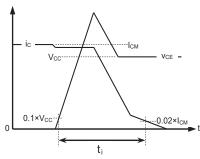


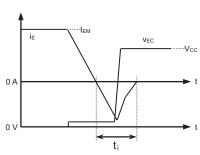


Switching characteristics test circuit and waveforms









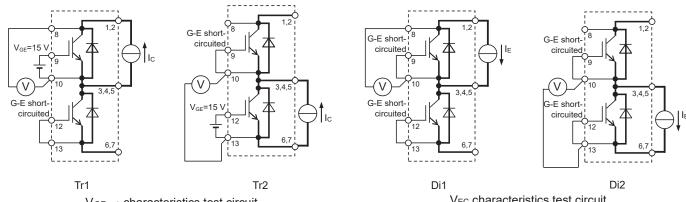
IGBT Turn-on switching energy

IGBT Turn-off switching energy

FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

#### **TEST CIRCUIT**



V<sub>EC</sub> characteristics test circuit

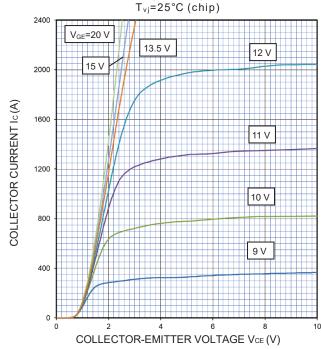
HIGH POWER SWITCHING USE **INSULATED TYPE** 

#### **PERFORMANCE CURVES**

#### **INVERTER PART**

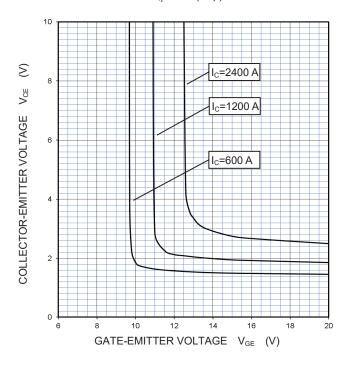
#### **OUTPUT CHARACTERISTICS**

#### (TYPICAL) T<sub>vi</sub>=25°C (chip)



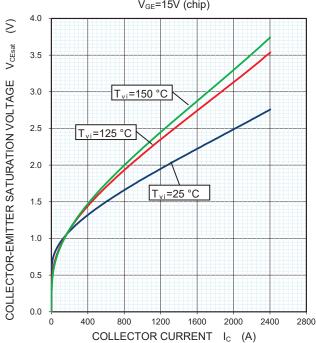
#### **COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS** (TYPICAL)

T<sub>vi</sub>=25°C (chip)



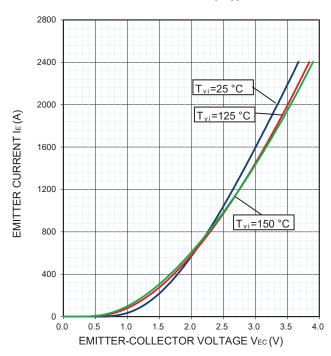
#### **COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS** (TYPICAL)

V<sub>GE</sub>=15V (chip)



#### FREE WHEELING DIODE **FORWARD CHARACTERISTICS** (TYPICAL)

G-E short-circuited (chip)



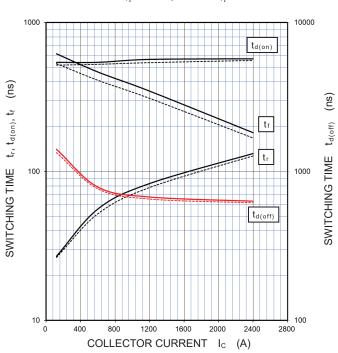
HIGH POWER SWITCHING USE **INSULATED TYPE** 

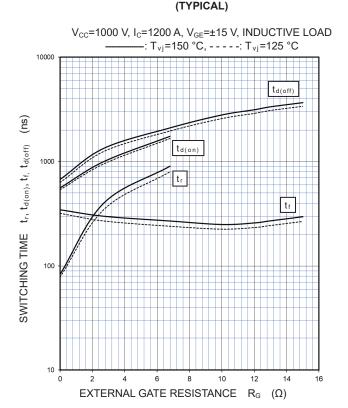
#### **PERFORMANCE CURVES**

#### **INVERTER PART**

#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

 $V_{CC}$ =1000 V,  $R_G$ =0  $\Omega$ ,  $V_{GE}$ =±15 V, INDUCTIVE LOAD -: T<sub>vj</sub>=150 °C, - - - -: T<sub>vj</sub>=125 °C

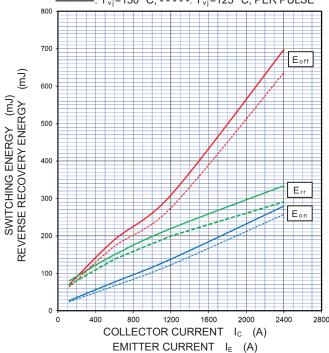




HALF-BRIDGE SWITCHING CHARACTERISTICS

#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V<sub>CC</sub>=1000 V, R<sub>G</sub>=0 Ω, V<sub>GE</sub>=±15 V, INDUCTIVE LOAD,  $T_{vj}$ =150 °C, - - - - -:  $T_{vj}$ =125 °C, PER PULSE



#### HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

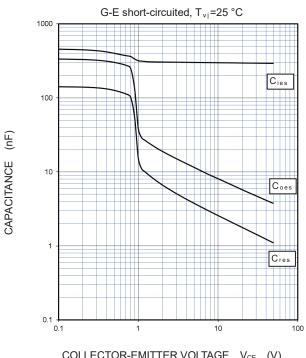
V<sub>CC</sub>=1000 V, I<sub>C</sub>/I<sub>E</sub>=1200 A, V<sub>GE</sub>=±15 V, INDUCTIVE LOAD, : T<sub>vj</sub>=150 °C, - - - - : T<sub>vj</sub>=125 °C, PER PULSE 1800 1600 (m) 1400 SWITCHING ENERGY (mJ) REVERSE RECOVERY ENERGY 1200 1000 800 600 400 200 EXTERNAL GATE RESISTANCE RG  $(\Omega)$ 

HIGH POWER SWITCHING USE **INSULATED TYPE** 

#### **PERFORMANCE CURVES**

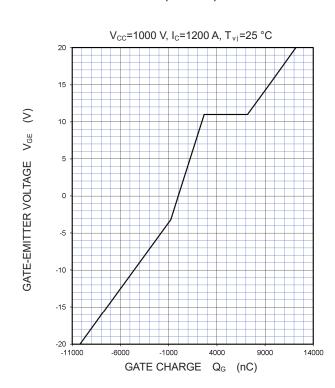
#### **INVERTER PART**

#### **CAPACITANCE CHARACTERISTICS** (TYPICAL)



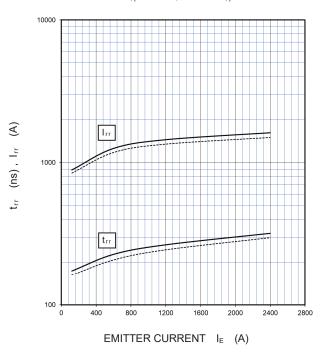
#### COLLECTOR-EMITTER VOLTAGE V<sub>CE</sub> (V)

#### **GATE CHARGE CHARACTERISTICS** (TYPICAL)

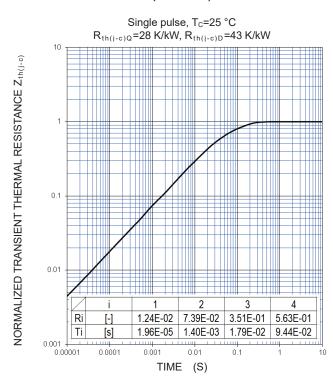


#### **FREE WHEELING DIODE** REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

 $V_{\text{CC}}$ =1000 V,  $R_{\text{G}}$ =0  $\Omega$ ,  $V_{\text{GE}}$ =±15 V, INDUCTIVE LOAD -: T<sub>vi</sub>=150 °C, - - - -: T<sub>vi</sub>=125 °C



#### TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

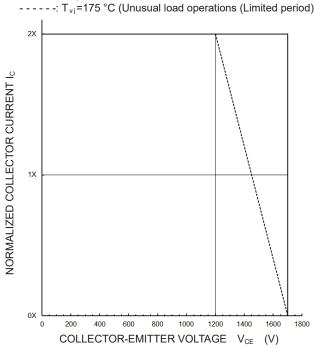


HIGH POWER SWITCHING USE INSULATED TYPE

#### **PERFORMANCE CURVES**

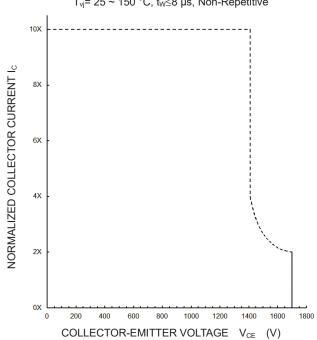
#### TURN-OFF SWITCHING SAFE OPERATIONG AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)

 $\begin{array}{c} V_{\text{CC}}{\leq}1200 \text{ V, } V_{\text{GE}}{=}\pm15 \text{ V, } R_{\text{G(off)}}{=}0{\sim}15 \text{ }\Omega, \\ -----: T_{v_i}{=}25{\sim}150 \text{ °C (Normal load operations (Continuous)} \\ -----: T_{v_i}{=}175 \text{ °C (Unusual load operations (Limited period)} \end{array}$ 

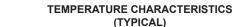


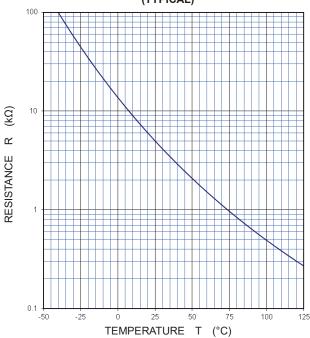
# SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)

 $V_{CC} \le 1200 \text{ V}, V_{GE} = \pm 15 \text{ V},$  $T_{vj} = 25 \sim 150 \text{ °C}, t_W \le 8 \text{ µs}, \text{Non-Repetitive}$ 



#### **NTC** thermistor part





Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

HIGH POWER SWITCHING USE INSULATED TYPE

### **Important Notice**

The information contained in this datasheet shall in no event be regarded as a guarantee of cond itions or characteristics. This product has to be used within its specified maximum ratings, and is su bject to customer's compliance with any applicable legal requirement, norms and standards.

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HIGH POWER SWITCHING USE INSULATED TYPE

### Keep safety first in your circuit designs!

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